Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10811977	TAKAYAMA ET AL.
Examiner	Art Unit
Chang, Rick K	3726

SEARCHED				
Class	Subclass	Date	Examiner	
29	863,854,861,865,866,867,33 F,33 M,745,747,748,749,750,751,753,761	12/22/06	RC	
72	416,16.2,16.8,17.3			
73	81-87			

SEARCH NOT	ES	•
Search Notes	Date	Examiner
EAST SEARCH	12/22/06	RC

INTERFERENCE SEARCH			
	,		
Class	Subclass	Date	Examine

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